

Notice of References Cited	Application/Control No. 10/816,855	Applicant(s)/Patent Under Reexamination OKANO, AKIHIRO	
	Examiner Neil P. Quinn	Art Unit 2676	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0165064	08-2004	Weitbruch et al.	348/173
	B	US-2002/0191846	12-2002	Crinon et al.	382/173
	C	US-2001/0035874	11-2001	Hamilton et al.	345/682
	D	US-4,722,005	01-1988	Ledenbach, Gregory W.	348/173
	E	US-2001/0035874	11-2001	Hamilton et al.	345/682
	F	US-6,313,878	11-2001	Jankowiak, Patrick Joseph	348/377
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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